

**Search Notes**

Application/Control No.

10/656,850

Examiner

Patrick J. Lee

Applicant(s)/Patent under  
Reexamination

YASAITIS, JOHN

Art Unit

2878

**SEARCHED**

Class	Subclass	Date	Examiner
250	214R, 214.1	2/15/06 3/6/06	PL
438	48, 57		PL
438	69		PL
257	222, 225		PL
257	228, 290		PL
257	431-432		PL
257	440		PL
Updated	search	6/27/2006	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	2/15/2006	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	3/6/2006	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	6/27/2006	PL